Ref #	Hits	Search Query	DBs	Default Operato	Plural s	Time Stamp
L1	2374	438/14.ccls.	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:26
L2	4048	438/17.ccls.	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:12
L3	45	438/19.ccls.	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:12
L4	304	438/21.ccls.	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:12
L5	240 [°]	1 and test adj wafer	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:12

L6	126	2 and test adj wafer	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR.	ON	2007/02/04 15:13
L7	0	3 and test adj wafer	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:13
L8	0	4 and test adj wafer	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:13
L9	14	5 and select\$3 with wafer with parameter	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:26
L10	9	6 and select\$3 with wafer with parameter	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:14

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L11	1	6 and select\$3 with wafer with parameter with value	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:15
L12	5.	5 and select\$3 with wafer with parameter with value	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:26
L13	5	12 and monitor\$4	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:17
L14	4	12 and monitor\$4 with one	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:17
L15		5 and select\$3 with best with wafer with parameter	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:18

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L16	0	6 and select\$3 with best with wafer with parameter	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04
L17	7	select\$3 with best with wafer with parameter	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:19
L18		select\$3 with best with wafer with one	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:20
L19	0	18 same process with paramter.	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:21
L20	3	18 same process with parameter	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:21

L21	34	Maeritz.in.	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:22
L22	0	21 same process with paramter	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:22
L23	0	21 and process with paramter	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:22
L24	499	438/5.ccls.	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:26
L25	16	24 and select\$3 with wafer with parameter	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:26

L26	3	24 and select\$3 with wafer with parameter with value	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:26
L27		24 and select\$3 with best with wafer with parameter	US-PGPU B; USPAT; USOCR; FPRS; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2007/02/04 15:26